


<b>Search Notes</b>  	<b>Application/Control No.</b>  10582906	<b>Applicant(s)/Patent Under Reexamination</b>  BARELLA ET AL.
	<b>Examiner</b>  Jennifer Kim	<b>Art Unit</b>  1617

SEARCHED			
Class	Subclass	Date	Examiner
514	221, 303, 419, 458, 561	4/24/2008	jmk

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search;STN (see search terms)	4/24/2008	jmk

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner